Application/Control No. Applicant(s)/Patent Under Reexamination 10/666,765 IYER, MAHESH ANANTHARAMA Notice of References Cited Examiner Art Unit Page 1 of 1 Joseph P. Hirl 2129 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В С US-D US-Ε US-US-F G US-Н US-USı US-J K US-US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Ţ **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) A. Chandra et al, AVPGEN - A Test Generator for Architecture Verification, 1995, IEEE, 1063-8210/95, 188-200 U

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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